Search Notes

Application/Control No.	Applicar Reexam
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10/530,135 Examiner

Shih-Chao Chen

Applicant(s)/Patent under
Reexamination
MIKAMI ET AL.
Art Unit

2821

SEARCHED				
Class	Subclass	Date	Examiner	
343	789, 792.5, 866, 867	4/18/2007	CHEN	
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INTERFERENCE SEARCHED				
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EAST (search updated).	4/18/2007	CHEN